

Diode EMCON 4 Medium Power Chip

FEATURES:

- 1200V EMCON 4 technology
- soft, fast switching
- low reverse recovery charge
- small temperature coefficient

This chip is used for:

• low / medium power modules



Applications:

• low / medium power drives

Chip Type	V_R	I _F	Die Size	Package
IDC15D120T6M	1200V	25A	4.28 x 3.40 mm ²	sawn on foil

MECHANICAL PARAMETER:

Raster size	4.28 x 3.40			
Area total / active	14.55 / 8.89	mm^2		
Anode pad size	3.326 x 2.446			
Thickness	110	μm		
Wafer size	150	mm		
Flat position	180	deg		
Max. possible chips per wafer	1026 pcs			
Passivation frontside	Photoimide			
Pad metall	3200 nm AlSiCu			
Backside metall	Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al, ≤500μm			
Reject ink dot size	Ø 0.65mm; max 1.2mm			
Recommended storage environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



Maximum Ratings

Parameter	Symbol	Symbol Condition		Unit	
Repetitive peak reverse voltage	V_{RRM}		1200	V	
Continuous forward current limited by	1		1)		
T _{jmax}	I _F			Α	
Maximum repetitive forward current	l		50		
limited by T _{jmax}	/ _{FRM}				
Maximum junction and storage temperature	$T_{\rm vj,max}$, $T_{\rm stg}$		-40+175	°C	
Reverse bias safe operating area ²⁾ (RBSOA)	$I_{F,max} = 50A$, $V_{R,max} = 1200V$, $T_{vj,op} \le 150$ °C, $P_{max} = $ tbd kW				

¹⁾ depending on thermal properties of assembly

Static Electrical Characteristics (tested on wafer), T_i=25 °C

Parameter	Symbol	Condi	Value			Unit	
raiailletei	Symbol	Condi	tions	min.	Тур.	max.	Onne
Reverse leakage current	I_{R}	V _R =1200V	<i>T_j</i> =25 °C			5.2	μΑ
Cathode-Anode breakdown Voltage	V _{Br}	I _R =0.25mA	<i>T_j</i> =25°C	1200			V
Forward voltage drop	V_{F}	I _F =25A	<i>T_j</i> =25 °C	1.35	1.7	2.05	V

Dynamic Electrical Characteristics inductive load (not subject to production test - verified by design/characterization)

Parameter	Symbol	Conditions		Value 2)			Unit
rarameter	Symbol			min.	Тур.	max.	
Peak reverse recovery current	I _{RM}	$I_F=A$ di/dt=A/ms $V_R=V$ $V_{GE}=-15V$	$T_j = 25 ^{\circ}\text{C}$ $T_j = 125 ^{\circ}\text{C}$ $T_j = 150 ^{\circ}\text{C}$		tbd		А
Reverse recovery charge	Q _r	$I_F=A$ di/dt=A/ms $V_R=V$ $V_{GE}=-15V$	$T_j = 25 ^{\circ}\text{C}$ $T_j = 125 ^{\circ}\text{C}$ $T_j = 150 ^{\circ}\text{C}$		tbd		μC
Reverse recovery energy	E _{rec}	$I_F=A$ di/dt=A/ms $V_R=V$ $V_{GE}=-15V$	$T_j = 25 ^{\circ}\text{C}$ $T_j = 125 ^{\circ}\text{C}$ $T_j = 150 ^{\circ}\text{C}$		tbd		mJ

 $^{^{2)}}$ values also influenced by parasitic L- and C- in measurement and package.

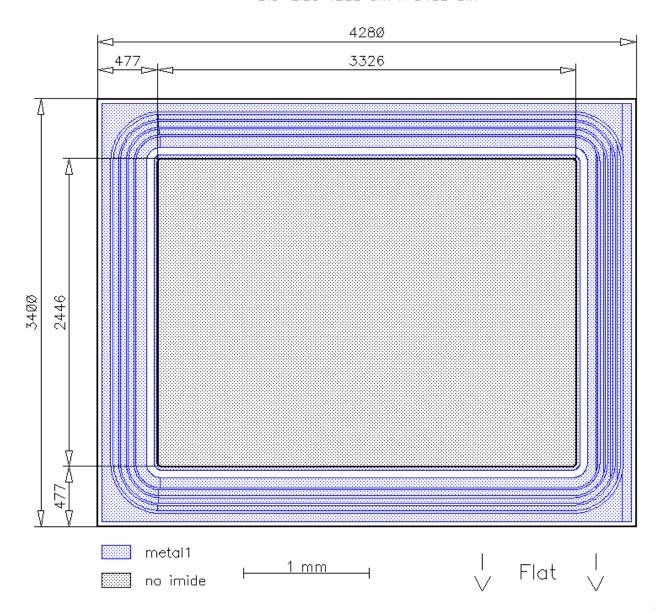
²⁾ not subject to production test - verified by design/characterisation



CHIP DRAWING:

L4669B MePo

Die-Size 4280 um x 3400 um





This chip data sheet refers to the device data sheet Description: AQL 0,65 for visual inspection according to failure catalog Electrostatic Discharge Sensitive Device according to MIL-STD 883 Test-Normen Villach/Prüffeld

Published by Infineon Technologies AG 81726 Munich, Germany © Infineon Technologies AG 2007 All Rights Reserved

Attention please!

The information herein is given to describe certain components and shall not be considered as warranted characteristics.

Terms of delivery and rights to technical change reserved.

We hereby disclaim any and all warranties, including but not limited to warranties of non-infringement, regarding circuits, descriptions and charts stated herein.

Infineon Technologies is an approved CECC manufacturer.

Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office in Germany or our Infineon Technologies Representatives world-wide (see address list).

Warnings

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and / or maintain and sustain and / or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.